

Notice of References Cited	Application/Control No. 10/090,520	Applicant(s)/Patent Under Reexamination ODOM, GARY	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,442,692	08-2002	Zilberman, Arkady G.	713/184
	B	US-6,766,456	07-2004	McKeeth, James	713/200
	C	US-4,621,334	11-1986	Garcia, John D.	382/115
	D	US-4,805,222	02-1989	Young et al.	382/115
	E	US-2001/0047488	11-2001	Verplaetse et al.	713/202
	F	US-4,964,163	10-1990	Berry, Thomas G.	713/183
	G	US-5,682,475	10-1997	Johnson et al.	713/202
	H	US-6,421,453	07-2002	Kanevsky et al.	382/115
	I	US-4,962,530	10-1990	Cairns, John P.	713/183
	J	US-5,161,190	11-1992	Cairns, John P.	713/183
	K	US-6,193,153	02-2001	Lambert, Francis	235/380
	L	US-5,442,342	08-1995	Kung, Kenneth C.	340/5.27
	M	US-6,205,204	03-2001	Morganstein et al.	379/67.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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	U	
	V	
	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,491,752	02-1996	Kaufman et al.	380/30
	B	US-5,226,172	07-1993	Seymour et al.	709/222
	C	US-6,209,104	03-2001	Jalili, Reza	726/18
	D	US-5,768,387	06-1998	Akiyama et al.	713/182
	E	US-6,657,614	12-2003	Ito et al.	345/168
	F	US-6,363,153	03-2002	Parker et al.	380/263
	G	US-2002/0002678	01-2002	CHOW et al.	713/169
	H	US-5,204,966	04-1993	Wittenberg et al.	726/6
	I	US-2004/0128508	07-2004	Wheeler et al.	713/170
	J	US-5,680,462	10-1997	Miller et al.	380/263
	K	US-4,288,659	09-1981	Atalla, Martin M.	380/281
	L	US-5,696,686	12-1997	Sanka et al.	700/110
	M	US-6,292,790	09-2001	Krahn et al.	705/50

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11102345 A	04-1999	Japan	FUKUDA, TETSUYA	G06F 15/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,218,738	08-1980	Matyas et al.	705/72
	B	US-6,647,400	11-2003	Moran, Douglas B.	707/205
	C	US-6,219,707	04-2001	Gooderum et al.	709/225
	D	US-5,721,780	02-1998	Ensor et al.	713/155
	E	US-5,226,080	07-1993	Cole et al.	713/183
	F	US-5,091,939	02-1992	Cole et al.	713/183
	G	US-6,311,272	10-2001	Gressel, Cami David	713/186
	H	US-5,889,866	03-1999	Cyras et al.	713/192
	I	US-5,913,024	06-1999	Green et al.	726/3
	J	US-5,867,647	02-1999	Haigh et al.	726/23
	K	US-6,332,195	12-2001	Green et al.	726/14
	L	US-6,647,498	11-2003	Cho, Jong-il	726/17
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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